

SIGC07T60NC

IGBT Chip in NPT-technology

FEATURES:

- 600V NPT technology
- 100µm chip ٠
- positive temperature coefficient •
- easy paralleling

- This chip is used for:
- **IGBT-Modules** ٠
- **Applications:** •
 - drives



| Chip Type | V _{CE} | I Cn | Die Size | Package | Ordering Code |
|-------------|-----------------|-------------|---------------------------|--------------|-----------------------|
| SIGC07T60NC | 600V | 6A | 2.6 x 2.6 mm ² | sawn on foil | Q67050-A4134- A001 |

MECHANICAL PARAMETER:

| Raster size | 2.6 x 2.6 | mm ² | | |
|---------------------------------|--|-----------------|--|--|
| Area total / active | 6.76 / 4.3 | | | |
| Emitter pad size | 1.11 x 1.78 | | | |
| Gate pad size | 0.5 x 0.7 | | | |
| Thickness | 100 | μm | | |
| Wafer size | 150 | mm | | |
| Flat position | 0 | deg | | |
| Max.possible chips per wafer | 2249 | | | |
| Passivation frontside | Photoimide | | | |
| Emitter metallization | 3200 nm Al Si 1% | | | |
| Collector metallization | 1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding | | | |
| Die bond | electrically conductive glue or solder | | | |
| Wire bond | AI, ≤500µm | | | |
| Reject Ink Dot Size | Ø 0.65mm ; max 1.2mm | | | |
| Recommended Storage Environment | store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C | | | |



MAXIMUM RATINGS:

| Parameter | Symbol | Value | Unit |
|---|-----------------------------------|----------|------|
| Collector-emitter voltage, Tj=25 °C | V _{CE} | 600 | V |
| DC collector current, limited by T _{jmax} | I _C | 1) | А |
| Pulsed collector current, t _p limited by T _{jmax} | I _{cpuls} | 18 | А |
| Gate emitter voltage | V _{GE} | ±20 | V |
| Operating junction and storage temperature | T _j , T _{stg} | -55 +150 | °C |

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on chip), $\mathit{T}_{j}\text{=}25\,$ °C, unless otherwise specified:

| Parameter | Symbol | Conditions | Value | | | Unit |
|--------------------------------------|----------------------|--|-------|------|------|------|
| | | Conditions | min. | typ. | max. | |
| Collector-emitter breakdown voltage | V _{(BR)CES} | V _{GE} =0V, I _C =500µA | 600 | | | |
| Collector-emitter saturation voltage | V _{CE(sat)} | V_{GE} =15V, I _C =6A | 1.7 | 2.0 | 2.5 | V |
| Gate-emitter threshold voltage | V _{GE(th)} | I_C =200µA, V_{GE} = V_{CE} | 4.5 | 5.5 | 6.5 | |
| Zero gate voltage collector current | I _{CES} | V _{CE} =600V, V _{GE} =0V | | | 0.5 | μA |
| Gate-emitter leakage current | I _{GES} | $V_{CE}=0V, V_{GE}=20V$ | | | 120 | nA |

DYNAMIC CHARACTERISTICS (tested at component):

| Parameter | Symbol | Conditions | Value | | | Unit |
|------------------------------|--------|-----------------------|-------|------|------|------|
| i alameter | | | min. | typ. | max. | |
| Input capacitance | Ciss | V _{CE} =25V, | | 222 | | pF |
| Output capacitance | Coss | $V_{GE}=0V$, | | - | | |
| Reverse transfer capacitance | Crss | f=1MHz | | 20 | | |

SWITCHING CHARACTERISTICS (tested at component), Inductive Load:

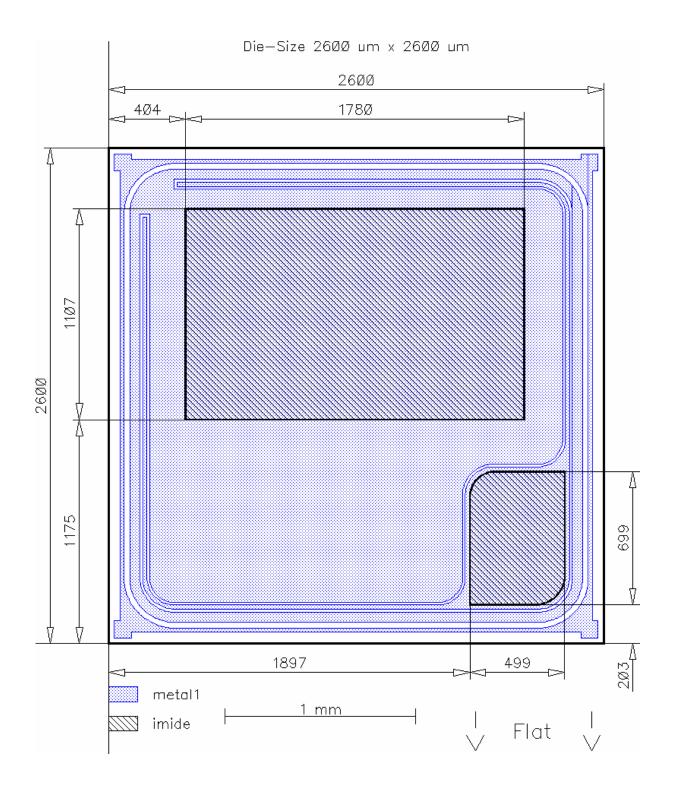
| Parameter | Symbol | Conditions ²⁾ | Value | | | Unit |
|---------------------|--------------------|--------------------------------------|-------|------|------|------|
| Falameter | | | min. | typ. | max. | |
| Turn-on delay time | t _{d(on)} | $T_{j}=125^{\circ}C$ $V_{CC}=300V$ | | 21 | | ns |
| Rise time | t _r | /c=6A | | 8 | | |
| Turn-off delay time | $t_{d(off)}$ | $V_{GE}=\pm 15V$ $R_{G}=54\Omega$ | | 110 | | |
| Fall time | t _f | 16-0112 | | 25 | | |

²⁾ values also influenced by parasitic L- and C- in measurement and package.





CHIP DRAWING:





FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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